



SHEET 1 OF 1

Form PTO 1449
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LIST OF REFERENCES CITED BY APPLICANT

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Hajime ITOH, et al.

FILING DATE

March 7, 2002

GROUP

2879

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
CL	AA	6,332,339	12/25/2001	T. KAWAGUCHI, et al.			
	AB	6,294,005	09/25/2001	S. INOUE, et al.			
	AC	6,251,811	06/26/2001	O. YANAGISAWA, et al.			
	AD	6,318,126	11/20/2001	Y. TAKEI, et al.			
	AE	6,334,336	01/01/2002	Y. TAKEI, et al.			
	AF	6,308,534	10/30/2001	Y. TAKEI, et al.			
	AG	6,321,572	11/27/2001	Y. TAKEI, et al.			
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	AL	5,922,097	07/13/99	H. KOBAYASHI, et al.			
CL	AM	6,128,924	10/10/2000	J. C. BANGE, et al.			
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	class	TRANSLATION YES	NO
CL	AO	2000-128549	05/09/2000	JAPAN (with English Abstract)	8-4		X
CL	AP	2000-239023	09/05/2000	JAPAN (with English Abstract)	8-4		X
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

Examiner

Date Considered

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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